

LINEAR INTEGRATED CIRCUITS

PREAMPLIFIER WITH ALC FOR CASSETTE RECORDERS

- EXCELLENT VERSATILITY in USE (V_s from 4 to 20V)
- HIGH OPEN LOOP GAIN
- LOW DISTORTION
- LOW NOISE
- LARGE AUTOMATIC LEVEL CONTROL RANGE
- GOOD SUPPLY RIPPLE REJECTION
- STEREO MATCHING BETTER THAN 3 dB

The TDA 1054M is a monolithic integrated circuit in a 16-lead dual in-line plastic package. The functions incorporated are:

- Low noise preamplifier
- Automatic level control system (ALC)
- High gain equalization amplifier
- Supply voltage rejection facility (SVRF).

It is intended as preamplifier in cassette tape recorders and players, dictaphones, compressor and expander in industrial equipments, Hi-Fi preamplifiers and in wire diffusion receivers; for stereo applications the ALC matching is better than 3 dB.

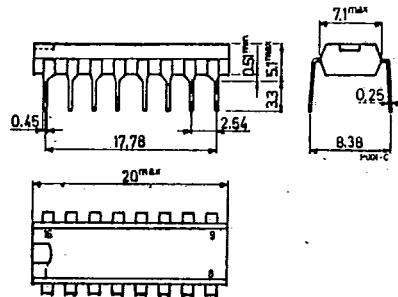
ABSOLUTE MAXIMUM RATINGS

| | | | |
|----------------|---|------------|----|
| V_s | Supply voltage | 20 | V |
| P_{tot} | Total power dissipation at $T_{amb} \leqslant 50^\circ\text{C}$ | 500 | mW |
| T_{stg}, T_j | Storage and junction temperature | -40 to 150 | °C |

ORDERING NUMBERS: 1 TDA 1054M mono applications
2 TDA 1054M stereo applications

MECHANICAL DATA

Dimensions in mm



1034 D-07

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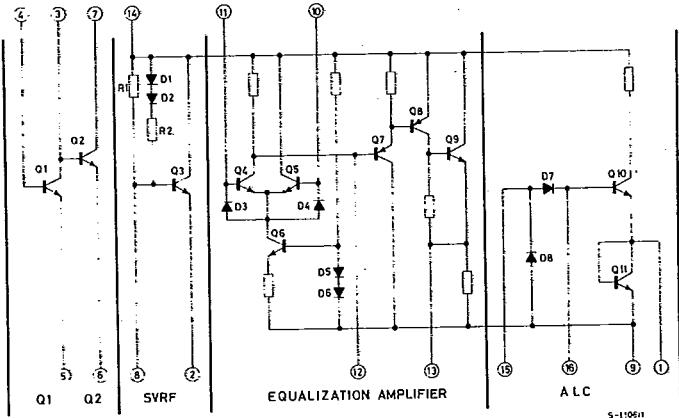
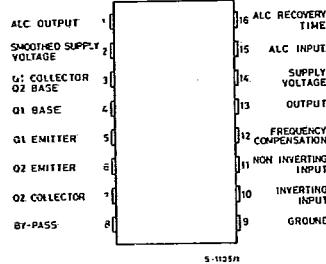
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SEMICONDUCTOR CORP

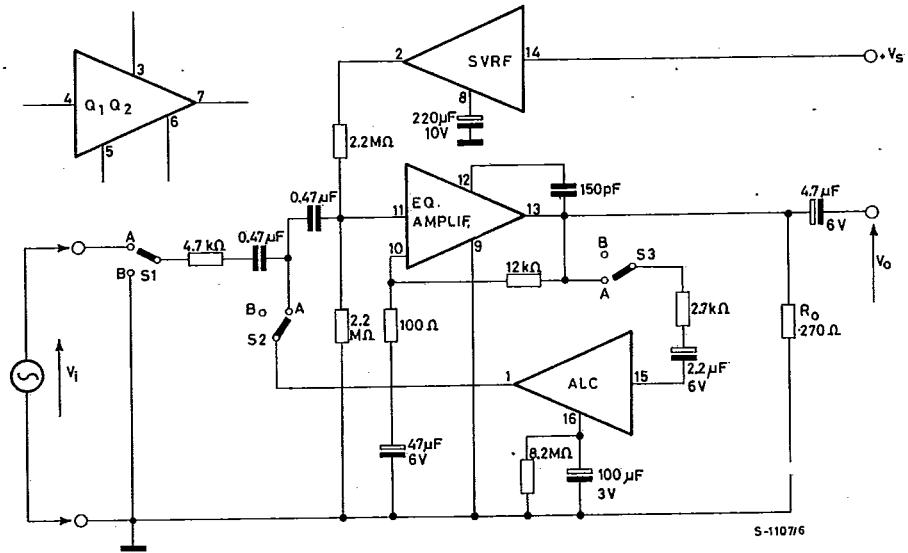
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CONNECTION AND SCHEMATIC DIAGRAMS

(top view)



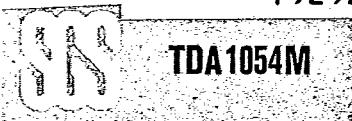
TEST CIRCUIT



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THERMAL DATA

| | | | |
|-----------------|-------------------------------------|---------|----------------------|
| $R_{th\ j-amb}$ | Thermal resistance junction-ambient | max 200 | $^{\circ}\text{C/W}$ |
|-----------------|-------------------------------------|---------|----------------------|

ELECTRICAL CHARACTERISTICS

(Refer to the test circuit, $T_{amb} = 25^{\circ}\text{C}$)

| Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--|---|------|------|------|--------------------------------------|
| V_s Supply voltage | | 4 | | 20 | V |
| I_d Quiescent drain current | $V_s = 9\text{V}$ $R_L = \infty$ $S1 = S2 = S3 = B$ | | 6 | | mA |
| h_{FE} DC current gain | $I_C = 0.1\text{ mA}$ $V_{CE} = 5\text{V}$ | 300 | 500 | | — |
| e_N Input noise voltage (Q1) | $I_C = 0.1\text{ mA}$ $V_{CE} = 5\text{V}$ $f = 1\text{ kHz}$ | | 2 | | $\frac{\text{nV}}{\sqrt{\text{Hz}}}$ |
| i_N Input noise current (Q1) | | | 0.5 | | $\frac{\text{pA}}{\sqrt{\text{Hz}}}$ |
| NF Noise figure (Q1) | $I_C = 0.1\text{ mA}$ $V_{CE} = 5\text{ V}$ $R_g = 4.7\text{ k}\Omega$ $B (-3\text{ dB}) = 20\text{ to }10,000\text{ Hz}$ | | 0.5 | 4 | dB |
| G_V Open loop voltage gain (for equalization amplifier) | $V_s = 9\text{V}$ $f = 1\text{ kHz}$ | | 60 | | dB |
| V_o Output voltage with A.L.C. | $V_s = 9\text{V}$ $V_i = 100\text{mV}$ $f = 1\text{ kHz}$ $S1 = S2 = S3 = A$ | | 1.1 | | V |
| R1 (for SVRF system) | see schematic diagram | | 7.5 | | $\text{k}\Omega$ |
| R2 (for SVRF system) | | | 120 | | Ω |
| e_N Input noise voltage (for equalization amplifier pin 11) | $V_s = 9\text{V}$ $R_g = 4.7\text{ k}\Omega$ $G_V = 40\text{ dB}$ $S1 = B$ $B (-3\text{ dB}) = 22\text{ Hz to }22\text{ KHz}$ | | 1.3 | | μV |
| V_{DR} Drop-out (between pins 14 and 2) | $V_s = 9\text{V}$ $I_d = 6\text{ mA}$ | | 0.8 | | V |



Fig. 1 - Equivalent input spot voltage and noise current vs. bias current (input transistor Q_1)

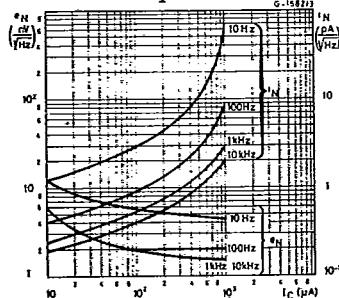


Fig. 2 - Equivalent input noise current vs. frequency (input transistor Q_1)

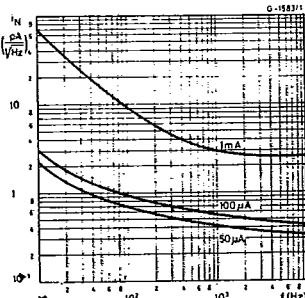


Fig. 3 - Equivalent input noise voltage vs. frequency (input transistor Q_1)

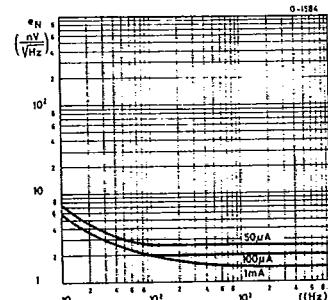


Fig. 4 - Noise figure vs. bias current (input transistor Q_1)

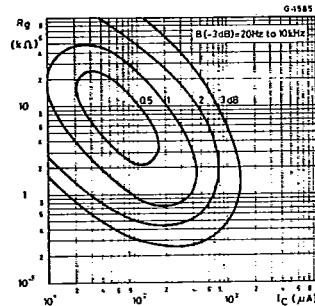


Fig. 5 - Optimum source resistance and minimum NF vs. bias current (input transistor Q_1)

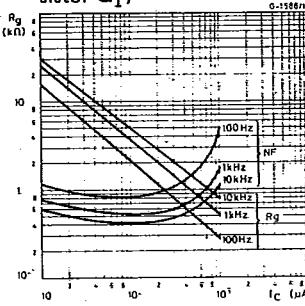


Fig. 6 - Current gain vs. collector current (input transistor Q_1)



Fig. 7 - Open loop gain vs. frequency (equalization amplifier)

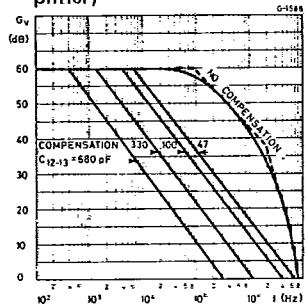
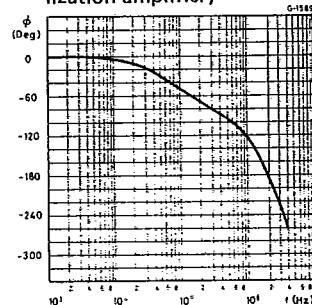


Fig. 8 - Open loop phase response vs. frequency (equalization amplifier)



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APPLICATION INFORMATION

Fig. 9 - Application circuit for battery/mains cassette player and recorder

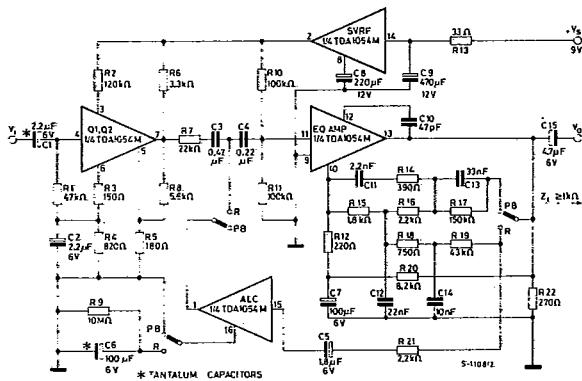
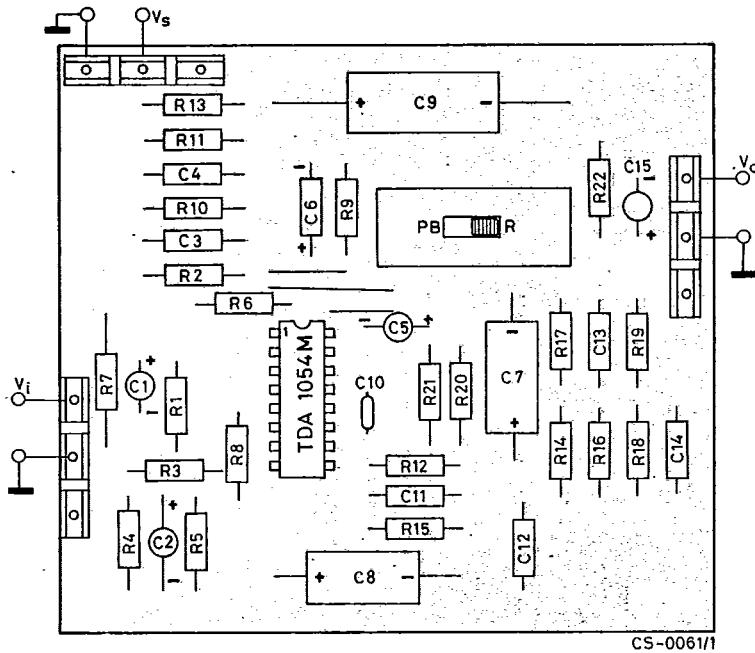


Fig. 10 - P.C. board and component layout for the circuit fig. 9 (1:1 scale)



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Typical performance of circuit in fig. 9(T_{amb} = 25°C, V_s = 9V)

| Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------------|---|------|----------------|------|----------------|
| PLAYBACK | | | | | |
| G _v | Voltage gain (open loop) f = 20 to 20,000 Hz | | 110 | | dB |
| G _v | Voltage gain (closed loop) f = 1 kHz | | 57 | | dB |
| Z _i | Input impedance f = 100 Hz f = 1 kHz f = 10 kHz | | 10 41 43 | | kΩ kΩ kΩ |
| Z _o | Output impedance f = 1 kHz | | 12 | 35 | Ω |
| B | Frequency response | | see fig. 12 | | |
| d | Distortion V _o = 1V f = 1 kHz | | 0.1 | | % |
| | Output background noise | | 1.3 | | mV |
| *** | Output weighted background noise Z _g = 300 Ω + 120 mH (DIN 45405) | | 1.3 | | mV |
| S+N/N | Signal to noise ratio V _o = 1.3V Z _g = 300 Ω + 120 mH | | 60 | | dB |
| SVR | Supply voltage ripple rejection at the output f _{ripple} = 100 Hz | | 30 | | dB |
| t _{on} ** | Switch-on time V _o = 1V | | 500 | | ms |
| RECORDING | | | | | |
| G _v | Voltage gain (open loop) f = 20 to 20,000 Hz | | 110 | | dB |
| G _v | Voltage gain (closed loop) f = 1 kHz | | 70 | | dB |
| B | Frequency response | | see fig. 14 | | |
| d* | Distortion without ALC V _o = 1.1V f = 1 kHz | | 0.3 | | % |
| d | Distortion with ALC V _o = 1.1V f = 10 kHz | | 0.4 | | % |
| ALC | Automatic level control range (for 3 dB of output voltage variation) V _i ≤ 40 mV f = 10 kHz | | 54 | | dB |
| V _o | Output voltage before clipping without ALC f = 1 kHz | | 2.3 | | V |
| V _o | Output voltage with ALC V _i = 30 mV f = 10 kHz | | 1.1 | | V |



Typical performance of circuit in fig. 9 (continued)

| Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|------------------------|---|------|------|------|------|
| t_l^{**} | $\Delta V_i = +40 \text{ dB}$ $f = 1 \text{ kHz}$ | | 75 | | ms |
| t_{set}^{**} | | | 300 | | ms |
| t_{rec}^{**} | $\Delta V_i = -40 \text{ dB}$ $f = 1 \text{ kHz}$ | | 150 | | s |
| t_{on}^{**} | $V_o = 1.1 \text{ V}$ | | 500 | | ms |
| $\frac{S+N}{N}^{****}$ | $V_o = 1.1 \text{ V}$ $R_g = 470 \Omega$ | | 64 | | dB |

* Measured with selective voltmeter

** This value depends on external network

*** When the DIN 45511 norm for frequency response is not mandatory the equalization peak at 10 kHz can be avoided — so halving the output noise

**** Weighted noise measurement (DIN 45405)

Fig. 11 - Limiting, level setting, recovery time

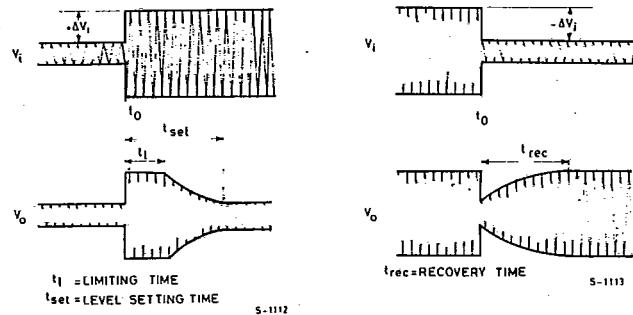


Fig. 12 - Relative frequency response for the circuit in fig. 9 (playback)

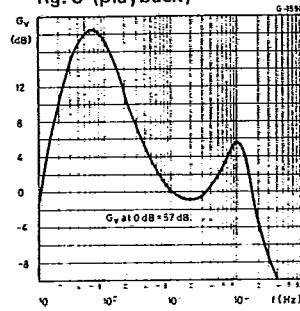


Fig. 13 - Distortion vs. frequency for the circuit in fig. 9 (playback)

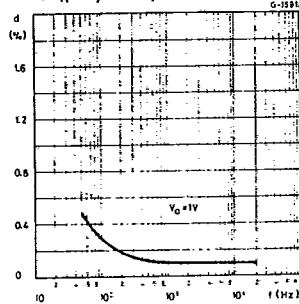
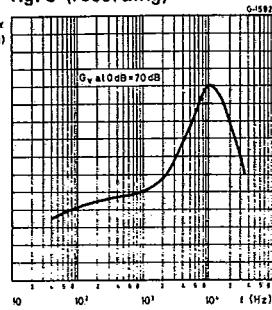


Fig. 14 - Relative frequency response for the circuit in fig. 9 (recording)



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Fig. 15 - Output voltage variation and distortion with ALC vs. input voltage for the circuit in fig. 9 (recording)

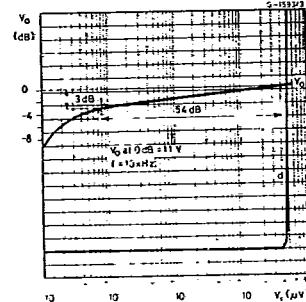


Fig. 16 - Distortion vs. frequency with ALC for the circuit in fig. 9 (recording)

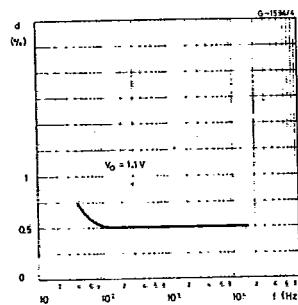


Fig. 17 - Limiting and level setting time vs. input signal variation

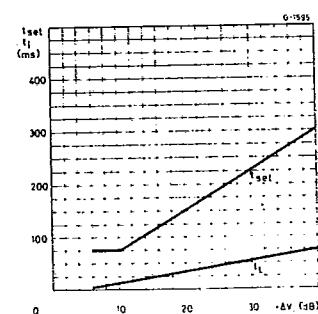
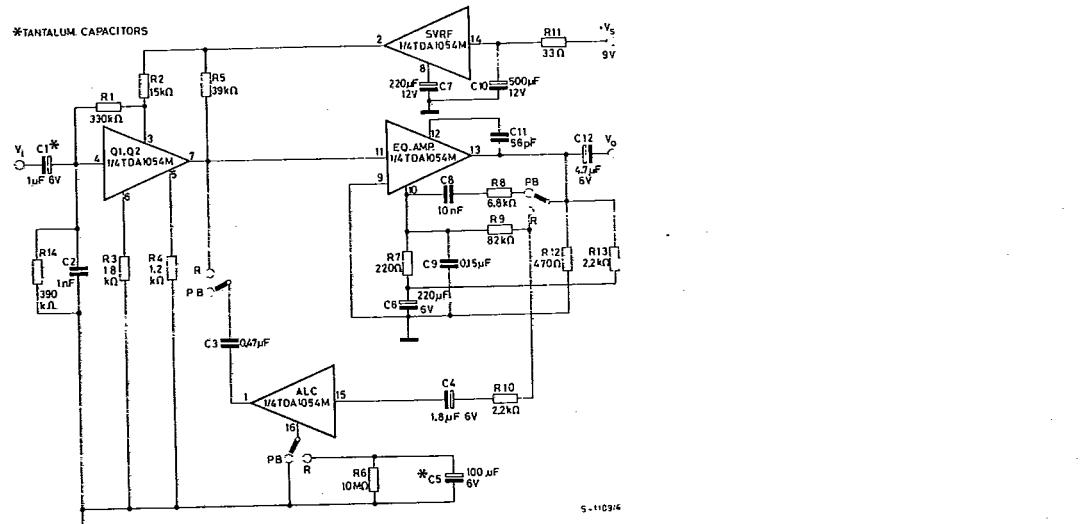


Fig. 18 - Low cost application circuit



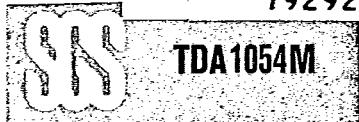
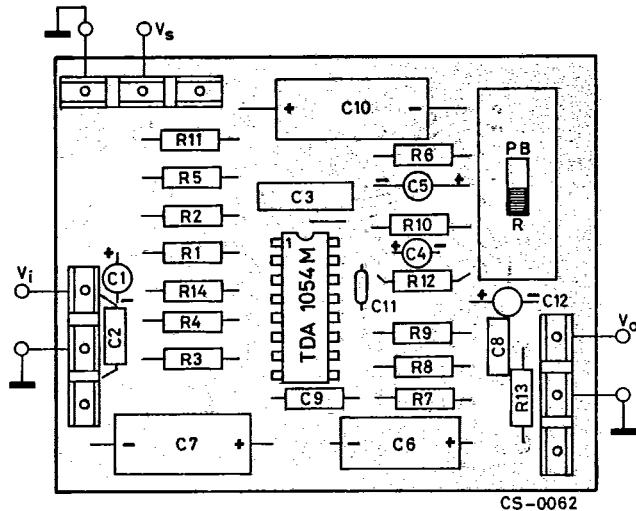


Fig. 19 - P.C. board and component layout for the circuit in fig. 18 (1:1 scale)



Typical performance of circuit in fig. 18

($T_{amb} = 25^\circ\text{C}$, $V_s = 9\text{V}$)

| Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|----------------------------------|---|--------------------------|------|------|
| PLAYBACK | | | | | |
| V_s | Supply voltage | | 5 | 12 | V |
| I_d | Quiescent drain current | | 18 | | mA |
| G_v | Voltage gain (closed loop) | $f = 1\text{ kHz}$ | 54 | | dB |
| B | Frequency response | $f = 100\text{ Hz}$ $f = 1\text{ kHz}$ $f = 6\text{ kHz}$ $f = 10\text{ kHz}$ $f = 60\text{ kHz}$ | 12 0 5 11 10 | | dB |
| d | Distortion | $V_o = 1\text{V}$ $f = 1\text{ kHz}$ | 0.6 | | % |
| e_N | Output weighted background noise | $Z_g = 300\Omega + 120\text{ mH}$ (DIN 45405) | 1.3 | | mV |

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Typical performance of circuit in fig. 18 (continued)

| Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|------------------|---|------|--------------|------|----------------|
| RECORDING | | | | | |
| G _V | Voltage gain (closed loop) f = 1 kHz | | 70 | | dB |
| B | Frequency response f = 140 Hz f = 1 kHz f = 10 kHz | | -3 0 4 | | dB dB dB |
| d | Distortion V _O = 1.1V f = 10 kHz | | 0.7 | | % |
| ALC | Range for 3 dB of output voltage variation V _I ≤ 40 mV f = 10 kHz | | 54 | | dB |

Fig. 20 - Complete cassette player and recorder

